

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Eliyahou Harari, Robert D. Norman and Sanjay Mehrotra
Assignee: SanDisk Corporation
Title: FLASH EEPROM SYSTEM
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Docket No.: 11587 M-10187-28C US Examiner: A. Tran
Group Art Unit: 2824

San Francisco, California
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COMMISSIONER FOR PATENTS
Washington, D. C. 20231

RESPONSE TO OFFICE ACTION

Dear Sir:

These remarks are in response to the first substantive Office Action mailed on July 30, 2001, requiring the applicants to provide support for the pending claims within one month. The present response provides this support. The Office Action also raised a number of additional issues, but as these are not subject to the one month, non-extendable time limit, they will be dealt with in a subsequent response that will follow presently.

Concerning the requirement to apply each limitation or element of claims 63-91 to the disclosure of the present application, support for claim 63 has previously been supplied as part of the Second Preliminary Amendment and Request for Interference filed on December 3, 1998. As it will be referred to in the course of providing support for the other claims, it is reproduced here for the Examiner's convenience. Patent number 5,172,338, that is referred to in the reproduced discussion below, is a continuation-in-part of application Serial No. 07/337,579 incorporated by reference into the present application and which forms the major portion of the material in the Preliminary Amendment filed concurrently with the present application, as discussed more fully in the Remarks beginning on page 27 of that Preliminary Amendment. The

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ITC document referred to in the reproduced discussion below was provided with the Second Preliminary Amendment and Request for Interference filed on December 3, 1998, and from which this discussion is copied.

Support for claim 63 (count 1) as found in the Request for Interference:

Support for the Proposed Count 1 in the Preliminary Amendment
to the Present Application

(N.B. All references in the right hand column are with respect to the Preliminary Amendment.)

<u>Count 1</u>	<u>Present Application</u> <u>(Preliminary Amendment)</u>
A non-volatile semiconductor memory device comprising:	The embodiments described are non-volatile semiconductor devices.
a plurality of bit lines;	The described memory system embodiment has a plurality of bit lines 1091, 1093, ... in Figure 12, and as described, for example, at page 7, lines 24-30
a plurality of word lines insulatively intersecting said bit lines;	The word lines are 1077, 1079, ... in Fig. 12 and described at p. 7, lns. 20-24. These intersect the bit lines, as also shown in figure 12. The details of this as "insulatively intersecting" can be seen in Fig. 9 and is described at p. 6, ln. 26 through p. 7, ln. 9, with an insulator, for example 1033, between word line 1027 and bit line 1019.

a memory cell array comprising a plurality of memory cells coupled to said bit lines and said word lines, each memory cell including a transistor with a charge storage portion;

a plurality of programming circuits coupled to said memory cell array

(i) for storing data which define whether or not write voltages are to be applied to respective of said memory cells,

(ii) for selectively applying said write voltages to a part of said memory cells, which part is selected according to the data stored in said plurality of programming circuits,

Fig. 12 shows the memory cell array, with cells coupled to bit lines and word lines, for example, cell 1063 coupled to 1091 and 1077. Fig. 9-11 show details of the cell with a floating gate, such as 1023, for charge storage. This is described at p. 6, lns. 1-17

The programming circuits are shown in Fig. 13 as 1190, 1200, 1210, and 1220. More detail is given in Fig. 22, showing them coupled to array 1060, and in Figs. 24 and 25, showing that they are a plurality. The description is at p. 19, ln. 1 through p. 21, ln. 28.

This storage occurs in latch 1721 of Fig. 24, which shows in more detail block 1200 of Fig. 13, and is described at p. 20, ln. 10 through p. 21, ln. 14 in conjunction with Fig. 23.

Block 1210 of Fig. 13 and Fig. 22, with description at p. 19, ln. 22 through p. 20, ln. 25 in conjunction with Figs. 23 and 24.

(iii) for determining actual written states of said memory cells, and

This occurs in the compare circuit of block 1200 of Fig. 13, shown in more detail in Fig. 24 and described at p. 20, ln. 26 through p.21, ln. 14.

(iv) for selectively modifying said stored data based on a predetermined logical relationship between the determined actual written states of said memory cells and the data stored in said plurality of programming circuits, thereby applying said write voltages only to memory cells which are not sufficiently written to achieve a predetermined written state.

Block 1210 of Fig. 13 in conjunction with blocks 1190, 1200, 1210, and 1220, as mentioned above. The program inhibit feature is described in more detail in Figs. 24 and 25 with description at p. 20, ln. 26 through p. 21 ln. 28.

The general structure of the memory array can be seen from Figure 12 of the present application as including a standard arrangement of bit lines, word lines, and memory cells. These cells are shown in detail in Figures 9-11. The description of the array is given in the disclosure from page 6, line 1 through page 8, line 21 of the Preliminary Amendment that was filed with, and became a part of, the present application. This description of the cells and their arrangement is that of count 1.

The general structure of the memory array can be seen from Figure 12 of the present application as including a standard arrangement of bit lines, word lines, and memory cells. These cells are shown in detail in Figures 9-11. The description of the array is given in the disclosure from page 6, line 1 through page 8, line 21 of the Preliminary Amendment that was filed with, and became a part of, the present application. This description of the cells and their arrangement is that of count 1.

The programming circuits recited in count 1 with the limitations (i)-(iv) are shown in Figure 13 as blocks 1190, 1200, 1210, 1220. Figure 22, and, particularly, Figures 24 and 25 show the relevant parts in more detail. The function of these circuits is explained at page 19, line 1 through page 21, line 28 under the general label of "Program Inhibit." It is this disclosure, along with the operation flow chart of Figure 23, that describes the programming circuit of count 1.

This is especially made clear in light of the Initial Determination by the Administrative Law Judge of the International Trade Commission ("ITC") with regard to Investigation No. 337-TA-382. This ITC proceeding resulted in claim 27 of related U.S. patent no. 5,172,338 being held valid and infringed. Sections III C and V.C. of this Initial Determination are the most pertinent to the present application, a copy of which is being filed herewith. In the present application, the numbers of the Figures are 8 higher than those of the corresponding Figures in the '338 patent, and the reference numbers are 1000 higher.

In particular, Section III.C pages 62-74 of that decision uphold the view that the present application's programming circuits are the same as those described in count 1. These pages relate to patent 5,172,338 of Mehrotra et al., the text and figures of its parent application having been incorporated into the present application by the Preliminary Amendment filed with the present application. The '338 patent is written to include multi-state memory, but also covers the use of binary memory cells as a simplified case. How the memory array and programming circuits described therein function, and, consequentially, relate to count 1, is described in detail in the opinion found on pages 62-74 of the ITC Initial determination. It is described more briefly here, where the references are again to the material incorporated into the present application by the earlier Preliminary Amendment.

Figure 13 is a schematic of the circuit, the memory array residing in block 1060 that is shown in more detail in figures 9-12. The programming circuits are in blocks 1190, 1200, 1210, and 1220. The compare circuit 1200 and inhibit circuit 1210 are shown in more detail in figures 24 and 25, respectively. Some comments need to be made about figure 24 and its simplification in the binary memory case.

The compare circuit 1200 determines whether a memory cell is correctly programmed or not. For a binary memory cell, these two choices---correct or not---are in direct one to one correspondence with the two states of the memory cell. For a multi-state memory cell with more than two states, this one to one correspondence breaks down: one state is correct, but all the others are not. This more general (L+1) state possibility requires the L XOR gates 1711-1715 of figure 24. In the binary state case, L=1 and there is only the single XOR gate 1711. This also reduces the NOR gate 1717 to a simple inverter for this one bit per cell case.

The one way latch 1721 then stores the data which defines whether or not write voltages are applied to the cell. This process is then done in an iterative manner until programming is complete. The read circuits 1220 of Figure 13 read out the result of an iteration, which is then compared in compare circuit 1200, and programming repeated by circuit 1210 until the circuit 1200 decides the cell is programmed. When the cell is programmed, the data bit in the one way latch 1721 is changed and, as a result, that particular cell is no longer written to. The circuit 1190 contains the initial data on which cells are to be programmed. In the multi-state case this serves as a point of reference, but can be thought of as simply a -1st iteration in the binary case of one bit per cell since there the latch 1721 determines whether the cell has achieved the predetermined state.

For these reasons, it is submitted to be clear that claim 1 of the '270 patent is supported by the present application disclosure, first filed on April 13, 1989.

Support for Claims 64-79

Concerning claim 64, this is step 3 of Figure 23 and is discussed in the Preliminary Amendment on page 20, lines 14-15. This is described in more detail above in the next to last paragraph of the discussion copied from the original Request for Declaration of Interference.

Concerning claim 65, see Figure 13 with the line "LOAD PGM DATA IN" from block 170 to block 190.

Concerning claim 66, this is described in the Preliminary Amendment with respect to Figure 24, beginning at page 20, line 26. In particular, see page 21, lines 3-

4, “The compare circuit 1200 performs the comparison of L bits in parallel”; and beginning at line 7 of the same page: “At the same time, the N outputs such as 1725, 1727 are passed through the AND gate...”.

Concerning claim 67, this is described in the discussion of block 1200, which is shown in Figure 24, and block 1210, which is shown in Figure 25 and receives the *n* “Cells Verified” signals along 731. The discussion of Figure 24 begins on page 20, line 26, of the Preliminary Amendment and the discussion of Figure 25 begins on page 21, line 15, of the Preliminary Amendment. In particular, note beginning on line 25 of page 21: “it follows that V_{PD} will be selectively passed onto those cells which are not yet verified. In this way, every time a programming pulse is applied, it is only applied to those cells which have not yet reached their intended states. This selective programming feature is especially necessary in implementing parallel programming and on chip verification in the multi-state case.” See also the comments related to the ITC initial determination following the support for claim 63 reproduced above from the Request for Declaration of Interference.

Concerning claim 68, the discussion for claim 67 also applies here. Concerning the “changing voltages of said bit lines...”, see the discussion of claim 74 below for more detail.

Concerning claim 69, see page 20, lines 20-22, of the Preliminary Amendment: “In figure 23(6), if any read bit fails to compare with the program data bit, a further programming voltage pulse from the program circuit is applied simultaneously to the chunk of cells.

Concerning claim 70, this is step 5 of Figure 23.

Concerning claim 71, the write voltages are applied either until the cells program, as described with respect to claim 70, or until a preset maximum number of pulses are applied, as described in U.S. patent number 5,095,344 at column 26, lines 31-35. (U.S. patent number 5,095,344 was formerly application serial number 204,175 that is incorporated by reference into the present application on page 21, lines 11-17, and other places.)

Concerning claim 72, the various elements of claim 63 are contained in 1130 of Figure 13. That these elements are arranged on a semiconductor substrate is described

on page 8 of the Preliminary Amendment, beginning at line 24: “In the larger system, an EEprom integrated circuit chip 1130...”.

Concerning claim 73, the described arrangement can be seen in Figure 13.

Concerning claim 74, in Figure 12, the bit lines 1093, 1093, ..., are connected to V_D 1105 through the drain multiplex 1109. In Figure 13, the PROGRAM CIRCUIT WITH INHIBIT block 1210 is connected to supply a voltage to V_D along line 1105, indicated to have a width n . More detail of block 1210 is given in Figure 25 that shows the n circuits 1801 to 1803 to connect to n bit lines through 1105. Figure 25 is described beginning at page 21, line 15 of the Preliminary Amendment.

Concerning claim 75, the “verify-termination detector” is again block 1200 of Figure 13, which is shown in more detail in Figure 24

Concerning claim 76, block 1200 is contained in 1130 of Figure 13. That these elements are arranged on a semiconductor substrate is described on page 8 of the Preliminary Amendment, beginning at line 24: “In the larger system, an EEprom integrated circuit chip 1130...”.

Concerning claim 77 and its dependent claim 78, these features are presented in the discussion of block 1200, which is shown in Figure 24, and block 1210, which is shown in Figure 25 and receives the n “Cells Verified” signals along 731. The discussion of Figure 24 begins on page 20, line 26, of the Preliminary Amendment and the discussion of Figure 25 begins on page 21, line 15, of the Preliminary Amendment. In particular, note beginning on line 25 of page 21: “it follows that V_{PD} will be selectively passed onto those cells which are not yet verified. In this way, every time a programming pulse is applied, it is only applied to those cells which have not yet reached their intended states. This selective programming feature is especially necessary in implementing parallel programming and on chip verification in the multi-state case.” See also the comments related to the ITC initial determination following the support for claim 63 reproduced above from the Request for Declaration of Interference.

Claim 79 corresponds to claim 63 plus the additional limitations of claims 64 and 65. Support for claim 79 is therefore given above with respect to these three claims.

Claim 80 repeats the limitations of claim 79, but with the preamble specifying a "system including" the device of claim 79. The various limitations of claim 80 are thus supported in the application as with claim 79, with the incorporation of the device into a system shown, for example, in Figure 1A of the present application.

Claims 81-91 are essentially the same as respective claims 66-76, except for tracing their dependence back to claim 80 instead of claim 63. (Claim 90 contains only part of the limitations of claim 75.) Consequently, support for the additional limitations of these claims is given above for the corresponding one of claims 66-76.

Conclusion

It is believed that the present application provides more than adequate support for all of the pending claims as presented above and that the requirements of 37 CFR 1.607(a)(5) have been fulfilled. As the remaining portions of the Office Action mailed on July 30, 2001, are not subject to the one month time limit, they will be responded to in due course. In the meantime, if the Examiner has any questions about this response, a telephone call to the undersigned is invited.

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Respectfully submitted,



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